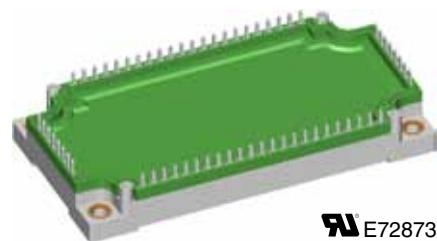
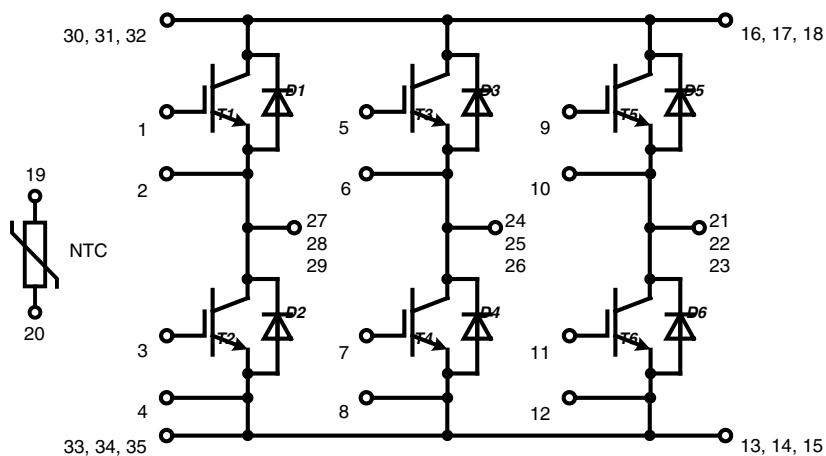


Six-Pack Trench IGBT

$V_{CES} = 1200\text{ V}$
 $I_{C25} = 110\text{ A}$
 $V_{CE(sat)} = 1.7\text{ V}$

Part name (Marking on product)

MWI75-12T8T



Pin configuration see outlines.

Features:

- Trench IGBT technology
- low saturation voltage
- low switching losses
- square RBSOA, no latch up
- high short circuit capability
- positive temperature coefficient for easy paralleling
- MOS input, voltage controlled
- ultra fast free wheeling diodes
- solderable pins for PCB mounting
- package with copper base plate

Application:

- AC motor drives
- Solar inverter
- Medical equipment
- Uninterruptible power supply
- Air-conditioning systems
- Welding equipment
- Switched-mode and resonant-mode power supplies

Package:

- "E3-Pack" standard outline
- Insulated copper base plate
- Soldering pins for PCB mounting
- Temperature sense included

Output Inverter T1 - T6

Ratings					
Symbol	Definitions	Conditions	min.	typ.	max.
V_{CES}	collector emitter voltage	$T_{VJ} = 25^\circ C$		1200	V
V_{GES}	max. DC gate voltage	continuous		± 20	V
V_{GEM}	max. transient collector gate voltage	transient		± 30	V
I_{C25}	collector current	$T_C = 25^\circ C$		110	A
I_{C80}		$T_C = 80^\circ C$		75	A
P_{tot}	total power dissipation	$T_C = 25^\circ C$		360	W
$V_{CE(sat)}$	collector emitter saturation voltage	$I_C = 75 A; V_{GE} = 15 V$	$T_{VJ} = 25^\circ C$ $T_{VJ} = 125^\circ C$	1.7 2.0	2.1
$V_{GE(th)}$	gate emitter threshold voltage	$I_C = 3 mA; V_{GE} = V_{CE}$	$T_{VJ} = 25^\circ C$	5.0	6.5
I_{CES}	collector emitter leakage current	$V_{CE} = V_{CES}; V_{GE} = 0 V$	$T_{VJ} = 25^\circ C$ $T_{VJ} = 125^\circ C$	1	3 mA mA
I_{GES}	gate emitter leakage current	$V_{GE} = \pm 20 V$		500	nA
C_{ies}	input capacitance	$V_{CE} = 25 V; V_{GE} = 0 V; f = 1 MHz$		5350	pF
$Q_{G(on)}$	total gate charge	$V_{CE} = 600 V; V_{GE} = 15 V; I_C = 75 A$		420	nC
$t_{d(on)}$	turn-on delay time	$T_{VJ} = 125^\circ C$ inductive load $V_{CE} = 600 V; I_C = 75 A$ $V_{GE} = \pm 15 V; R_G = 4.7 \Omega$ $L_S = 70 nH$		270	ns
t_r	current rise time			50	ns
$t_{d(off)}$	turn-off delay time			400	ns
t_f	current fall time			340	ns
E_{on}	turn-on energy per pulse			7	mJ
E_{off}	turn-off energy per pulse			10	mJ
RBSOA	reverse bias safe operating area	$V_{GE} = \pm 15 V; R_G = 4.7 \Omega;$ $V_{CEK} = 1200 V$		150	A
SCSOA	short circuit safe operating area	$T_{VJ} = 125^\circ C$ $V_{CE} = 900 V; V_{GE} = \pm 15 V;$ $R_G = 4.7 \Omega$; non-repetitive			
t_{sc}	short circuit duration			10	μs
I_{sc}	short circuit current			300	A
R_{thJC}	thermal resistance junction to case	(per IGBT)		0.35	K/W

Output Inverter D1 - D6

Ratings					
Symbol	Definitions	Conditions	min.	typ.	max.
V_{RRM}	max. repetitive reverse voltage	$T_{VJ} = 25^\circ C$		1200	V
I_{F25}	forward current	$T_C = 25^\circ C$		135	A
I_{F80}		$T_C = 80^\circ C$		90	A
V_F	forward voltage	$I_F = 100 A; V_{GE} = 0 V$	$T_{VJ} = 25^\circ C$ $T_{VJ} = 125^\circ C$	1.95 1.95	2.2 V V
Q_{rr}	reverse recovery charge	$T_{VJ} = 125^\circ C$ $V_R = 600 V$ $di_F/dt = -1600 A/\mu s$ $I_F = 100 A; V_{GE} = 0 V$		12.5	μC
I_{RM}	max. reverse recovery current			100	A
t_{rr}	reverse recovery time			350	ns
E_{rec}	reverse recovery energy			4	mJ
R_{thJC}	thermal resistance junction to case	(per diode)		0.4	K/W

 $T_C = 25^\circ C$ unless otherwise stated

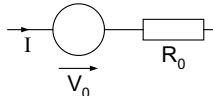
Temperature Sensor NTC

Ratings						
Symbol	Definitions	Conditions	min.	typ.	max.	Unit
R_{25}	resistance		$T_c = 25^\circ\text{C}$	4.75	5.0	$\text{k}\Omega$
$B_{25/50}$				3375	5.25	K

Module

Ratings						
Symbol	Definitions	Conditions	min.	typ.	max.	Unit
T_{VJ}	operating temperature		-40		125	$^\circ\text{C}$
T_{VJM}	max. virtual junction temperature				150	$^\circ\text{C}$
T_{stg}	storage temperature		-40		125	$^\circ\text{C}$
V_{ISOL}	isolation voltage	$I_{ISOL} \leq 1 \text{ mA}; 50/60 \text{ Hz}$			2500	V~
CTI	comparative tracking index				200	
M_d	mounting torque (M5)		2.7		3.3	Nm
d_s	creep distance on surface		10			mm
d_A	strike distance through air		7.5			mm
$R_{pin-chip}$	resistance pin to chip			2.5		$\text{m}\Omega$
R_{thCH}	thermal resistance case to heatsink	with heatsink compound		0.02		K/W
Weight				300		g

0.0 Equivalent Circuits for Simulation



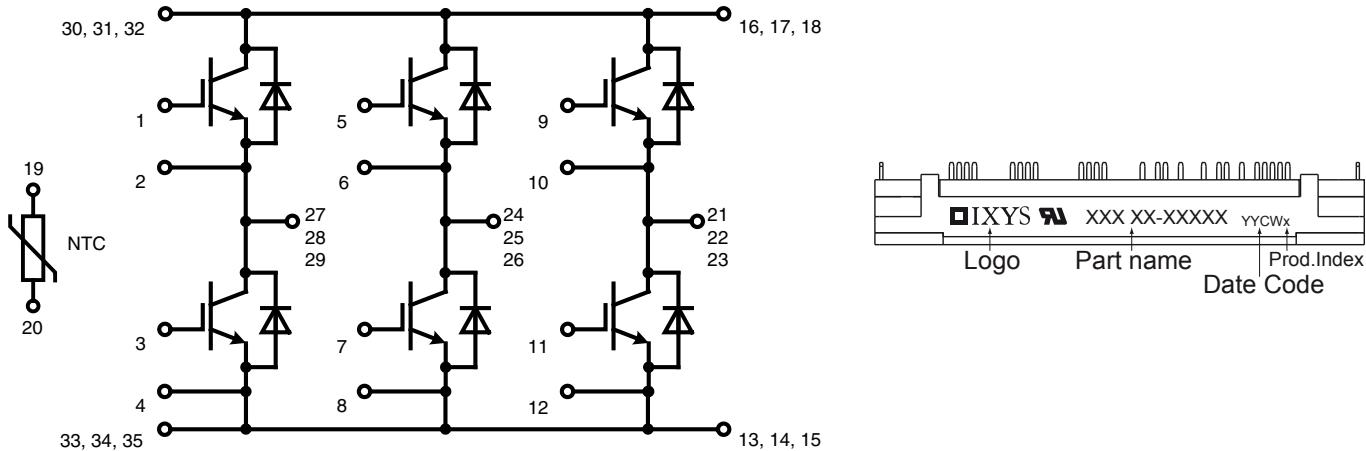
Ratings

Symbol	Definitions	Conditions	min.	typ.	max.	Unit
V_0	IGBT	$T_1 - T_6$		1.0		V
R_0				13.3		$\text{m}\Omega$
V_0	Diode	$D1 - D6$		1.09		V
R_0				9.1		$\text{m}\Omega$
R_1						
R_2						
R_3						
R_4						
τ_1						
τ_2						
τ_3						
τ_4						

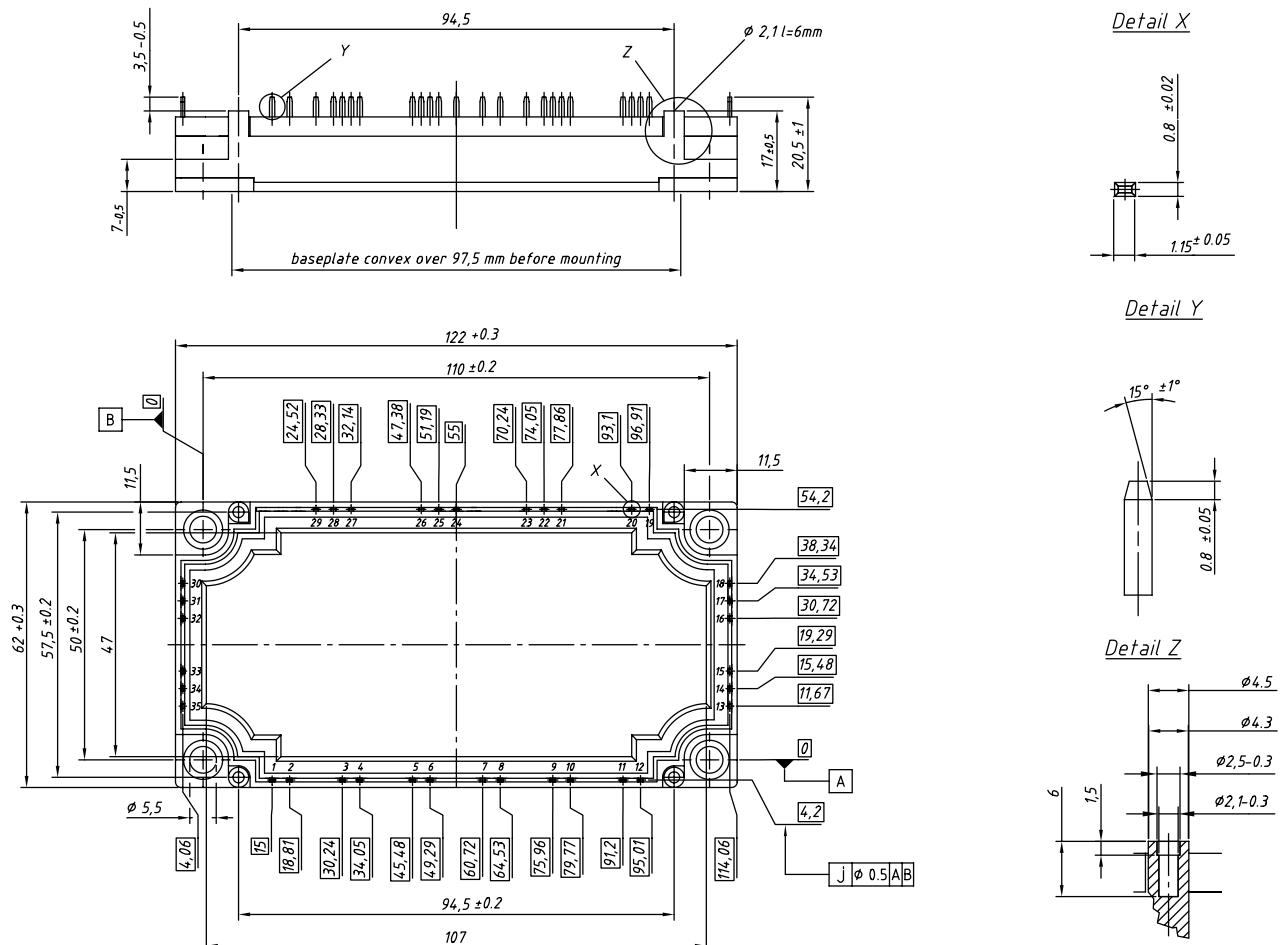
$Z_{th}(t) = \sum_{i=1}^n [R_i \cdot (1 - \exp(-\frac{t}{\tau_i}))]$
 $\tau_i = R_i \cdot C_i$

IGBT **Diode**

$T_c = 25^\circ\text{C}$ unless otherwise stated

Circuit Diagram**Outline Drawing**

Dimensions in mm (1 mm = 0.0394")

**Product Marking**

Ordering	Part Name	Marking on Product	Delivering Mode	Base Qty	Ordering Code
Standard	MWI75-12T8T	MWI75-12T8T	Box	5	502425

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Inverter T1 - T6

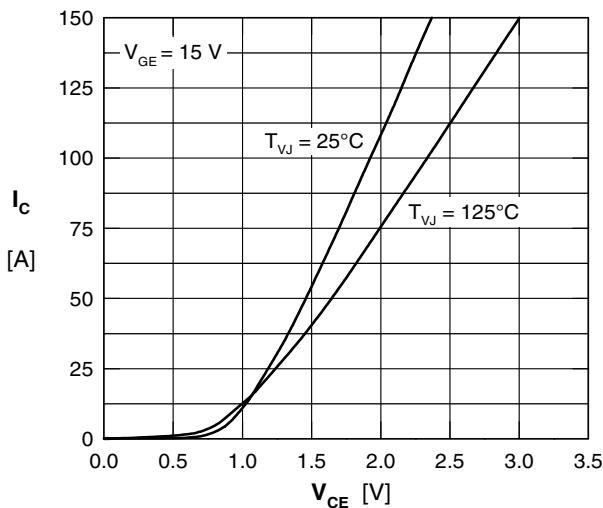


Fig. 1 Typ. output characteristics

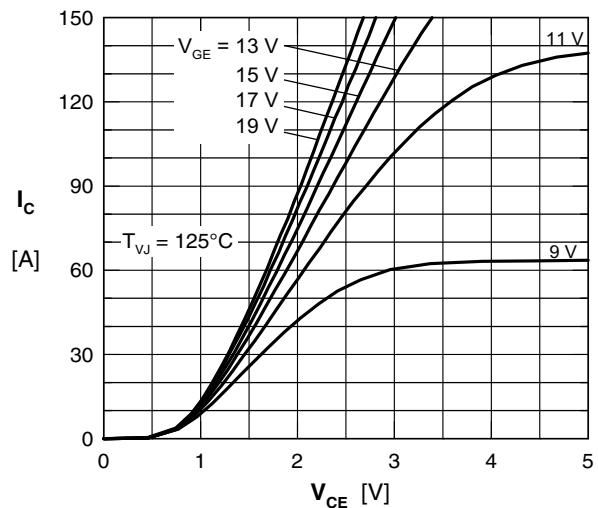


Fig. 2 output characteristics

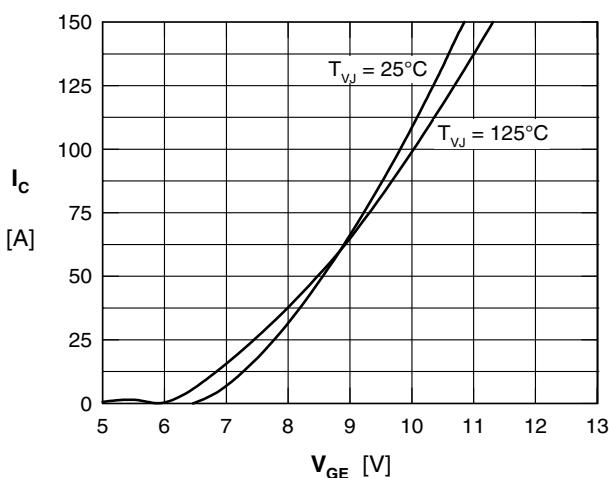


Fig. 3 Typ. transfer characteristics

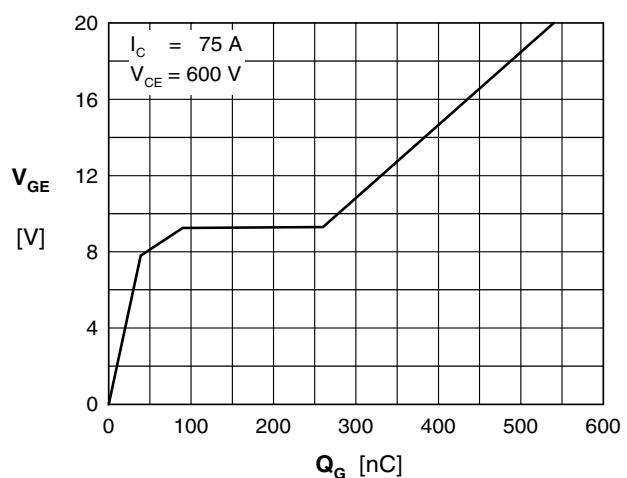


Fig. 4 Typ. turn-on gate charge

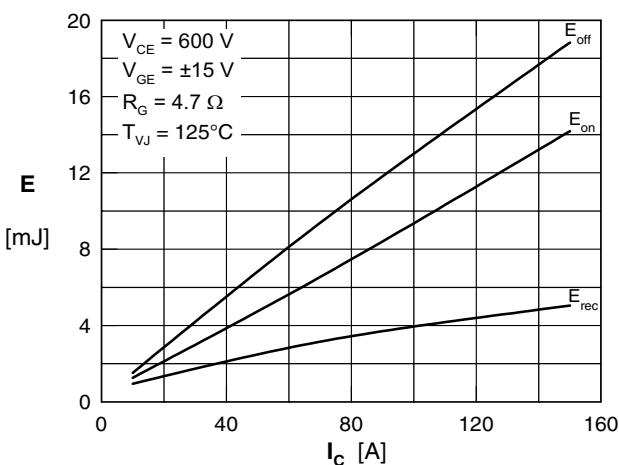


Fig. 5 Typ. switching energy vs. collector current

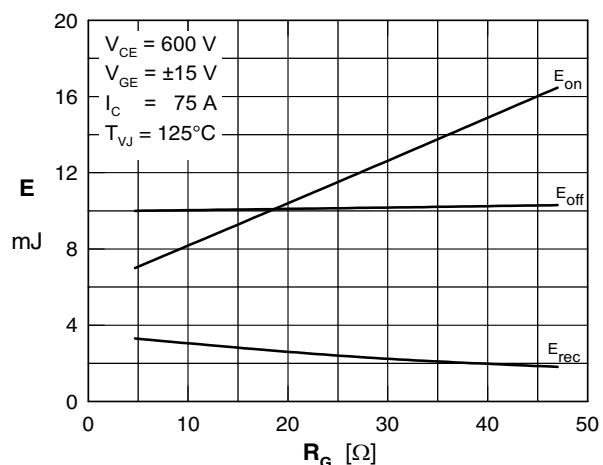


Fig. 6 Typ. switching energy vs. gate resistance

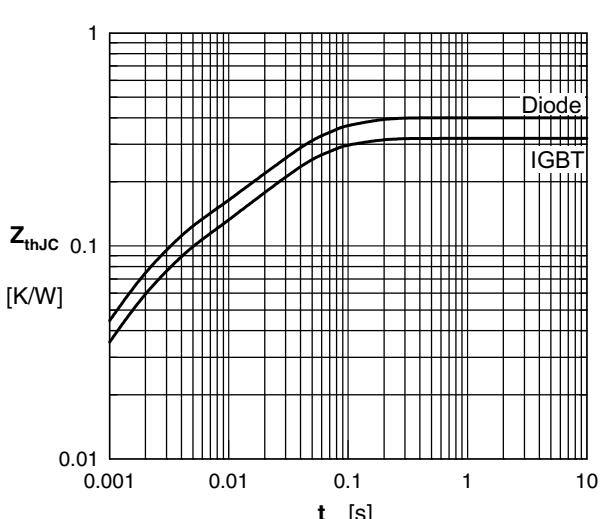
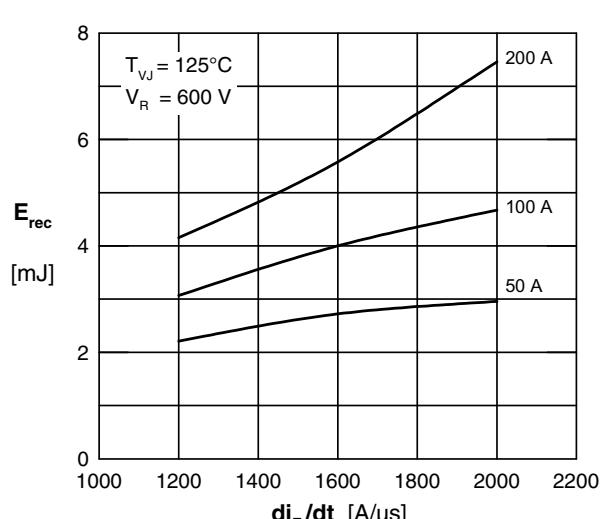
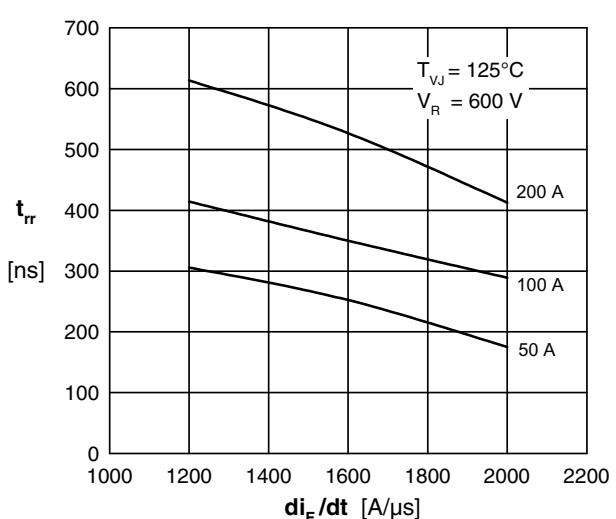
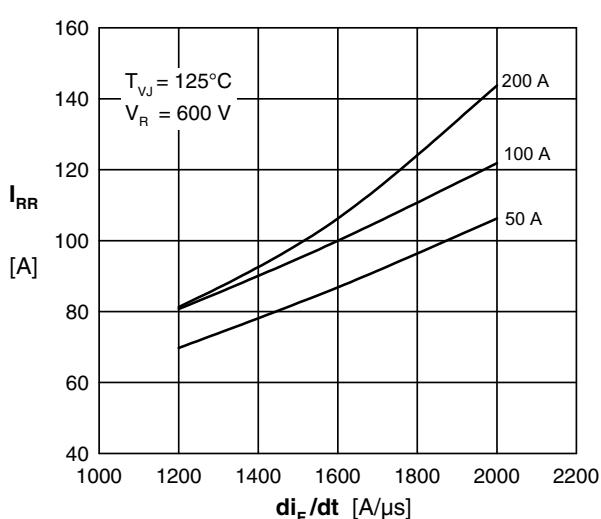
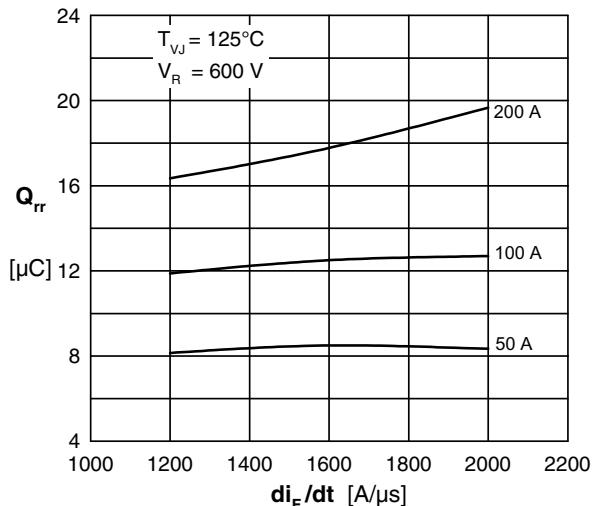
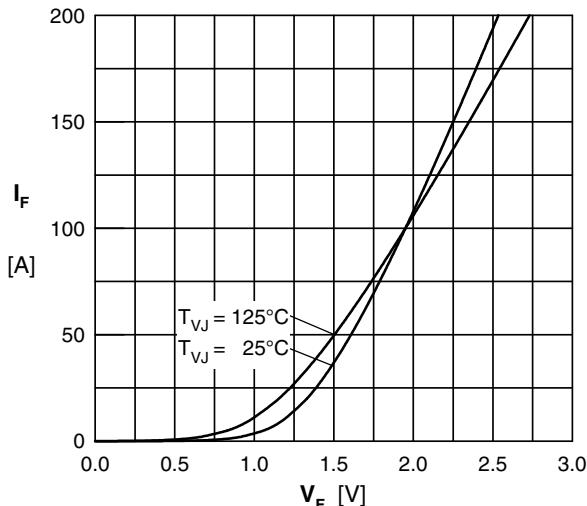
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Inverter D1 - D6



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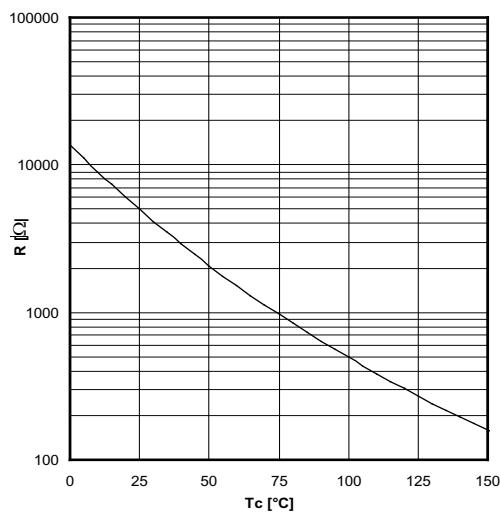
NTC

Fig. 13 Typ. NTC resistance vs. temperature